512K (64K x 8)

3-Volt Only

PEROM

CMOS Flash

Features

- Single 3.3 V ± 10% Supply
- Three-Volt-Only Read and Write Operation
- Software Protected Programming
- Low Power Dissipation

15 mA Active Current

- 20 µA CMOS Standby Current
- Fast Read Access Time 200 ns **Sector Program Operation**

Single Cycle Reprogram (Erase and Program)

512 Sectors (128 bytes/sector)

Internal Address and Data Latches for 128 Bytes

- Fast Sector Program Cycle Time 20 ms Max.
- Internal Program Control and Timer
- **DATA Polling for End of Program Detection**
- High Reliability CMOS Technology 1000 Program Cycles per Sector

10-Year Data Retention

- CMOS and TTL Compatible Inputs and Outputs
- **Commercial and Industrial Temperature Ranges**

Description

The AT29LV512 is a three-volt-only in-system Flash Programmable Erasable Read Only Memory (PEROM). Its 512K of memory is organized as 65,536 words by 8 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 200 ns with power dissipation of just 54 mW over the commercial temperature range. When the device is deselected, the CMOS standby current is less than 20 μ A.

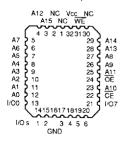
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Pin Configurations

Pin Name	Function
A0 - A15	Addresses
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
1/00 - 1/07	Data Inputs/Outputs
NC	No Connect

DIP Top View NC C C C A15 C C A15 C C A16 C C A17 C C A17 C C A17 C C A17 Vcc NC A15 30 A12 29 A14 28 27 26 25 24 23 A10 CE A1 C A0 C I/O0 C I/O1 C I/O2 C GND C 22 21 20 1/07 13 1/06 14 19 1/05 15 1/04 18 1/03

PLCC, LCC Top View



Note. PLCC package pin 30 is a DON'T CONNECT

TSOP Top View Type 1



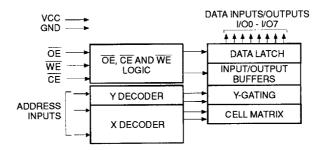


Description (Continued)

To allow for simple in-system reprogrammability, the AT29LV512 does not require high input voltages for programming. Three-volt-only commands determine the operation of the device. Reading data out of the device is similar to reading from an EPROM. Reprogramming the AT29LV512 is performed on a sector basis; 128 bytes of data are loaded into the device and then simultaneously programmed.

During a reprogram cycle, the address locations and 128 bytes of data are captured at microprocessor speed and internally latched, freeing the address and data bus for other operations. Following the initiation of a program cycle, the device will automatically erase the sector and then program the latched data using an internal control timer. The end of a program cycle can be detected by DATA polling of I/O7. Once the end of a program cycle has been detected, a new access for a read or program can begin.

Block Diagram



Device Operation

READ: The AT29LV512 is accessed like an EPROM. When \overline{CE} and \overline{OE} are low and \overline{WE} is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in the high impedance state whenever \overline{CE} or \overline{OE} is high. This dual-line control gives designers flexibility in preventing bus contention.

SOFTWARE DATA PROTECTION PROGRAMMING: The AT29LV512 has 512 individual sectors, each 128 bytes. Using the software data protection feature, byte loads are used to enter the 128 bytes of a sector to be programmed. The AT29LV512 can only be programmed or reprogrammed using the software data protection feature. The device is programmed on a sector basis. If a byte of data within the sector is to be changed, data for the entire 128-byte sector must be loaded into the device. The AT29LV512 automatically does a sector erase prior to loading the data into the sector. An erase command is not required.

Software data protection protects the device from inadvertent programming. A series of three program commands to specific addresses with specific data must be presented to the device before programming may occur. After writing the three-byte command sequence (and after twc), the entire device is protected. The same three program commands must begin each program operation. All software program commands must obey the sector program timing specifications. Power transitions will not

reset the software data protection feature, however the software feature will guard against inadvertent program cycles during power transitions.

Any attempt to write to the device without the three-byte command sequence will start the internal write timers. No data will be written to the device; however, for the duration of twc, a read operation will effectively be a polling operation.

After the software data protection's three-byte command code is given, a byte load is performed by applying a low pulse on the \overline{WE} or \overline{CE} input with \overline{CE} or \overline{WE} low (respectively) and \overline{OE} high. The address is latched on the falling edge of \overline{CE} or \overline{WE} , whichever occurs last. The data is latched by the first rising edge of \overline{CE} or \overline{WE} .

The 128 bytes of data must be loaded into each sector. Any byte that is not loaded during the programming of its sector will be erased to read FFh. Once the bytes of a sector are loaded into the device, they are simultaneously programmed during the internal programming period. After the first data byte has been loaded into the device, successive bytes are entered in the same maner. Each new byte to be programmed must have its high to low transition on \overline{WE} (or \overline{CE}) within 150 μs of the low to high transition is not detected within 150 μs of the last low to high

continued on next page

Device Operation (Continued)

transition, the load period will end and the internal programming period will start. A7 to A15 specify the sector address. The sector address must be valid during each high to low transition of $\overline{\text{WE}}$ (or $\overline{\text{CE}}$). A0 to A6 specify the byte address within the sector. The bytes may be loaded in any order; sequential loading is not required.

HARDWARE DATA PROTECTION: Hardware features protect against inadvertent programs to the AT29LV512 in the following ways: (a) VCC sense—if VCC is below 1.8 V (typical), the program function is inhibited. (b) VCC power on delay—once VCC has reached the VCC sense level, the device will automatically time out 10 ms (typical) before programming. (c) Program inhibit—holding any one of \overline{OE} low, \overline{CE} high or \overline{WE} high inhibits program cycles. (d) Noise filter—pulses of less than 15 ns (typical) on the \overline{WE} or \overline{CE} inputs will not initiate a program cycle.

INPUT LEVELS: While operating with a 3.3 V $\pm 10\%$ power supply, the address inputs and control inputs (\overline{OE} , \overline{CE} and \overline{WE}) may be driven from 0 to 5.5 V without adversely affecting the operation of the device. The I/O lines can only be driven from 0 to 3.6 volts.

PRODUCT IDENTIFICATION: The product identification mode identifies the device and manufacturer as Atmel. It may be accessed by hardware or software operation. The hardware operation mode can be used by an external programmer to identify the correct programming algorithm for the Atmel product. In addition, users may wish to use the software product identifica-

tion mode to identify the part (i.e. using the device code), and have the system software use the appropriate sector size for program operations. In this manner, the user can have a common board design for 256K to 4-megabit densities and, with each density's sector size in a memory map, have the system software apply the appropriate sector size.

For details, see Operating Modes (for hardware operation) or Software Product Identification. The manufacturer and device code is the same for both modes.

DATA POLLING: The AT29LV512 features DATA polling to indicate the end of a program cycle. During a program cycle an attempted read of the last byte loaded will result in the complement of the loaded data on I/O7. Once the program cycle has been completed, true data is valid on all outputs and the next cycle may begin. DATA polling may begin at any time during the program cycle.

TOGGLE BIT: In addition to DATA polling the AT29LV512 provides another method for determining the end of a program or crase cycle. During a program or erase operation, successive attempts to read data from the device will result in I/O6 toggling between one and zero. Once the program cycle has completed, I/O6 will stop toggling and valid data will be read. Examining the toggle bit may begin at any time during a program cycle.

OPTIONAL CHIP ERASE MODES: The entire device may be erased by either using a six-byte software code or high voltage. For details, please contact Atmel.

Absolute Maximum Ratings*

Temperature Under Bias 55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including N.C. Pins) with Respect to Ground0 6 V to +6.25 V
All Output Voltages with Respect to Ground0 6 V to Vcc +0 6 V
Voltage on A9 (including N.C. Pins) with Respect to Ground0.6 V to +13 5 V

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Pin Capacitance $(f = 1 \text{ MHz}, T = 25^{\circ}\text{C})^{(1)}$

_	Тур	Max	Units	Conditions
Cin	4	6	pF	VIN = 0 V
Cout	8	12	pF	Vout = 0 V

Note: 1. These parameters are characterized and not 100% tested





D.C. and A.C. Operating Range

		AT29LV512-20	AT29LV512-25
Operating	Com.	0°C - 70°C	0°C - 70°C
Temperature (Case)	Ind.	-40°C - 85°C	-40°C - 85°C
Vcc Power Supply		3.3 V ± 0.3 V	3.3 V ± 0.3 V

Operating Modes

Mode	CE	ŌĒ	WE	Ai	I/O
Read	ViL	VIL	ViH	Ai	Dout
Program ⁽²⁾	VIL	ViH	VIL	Ai	Din
Standby/Write Inhibit	ViH	X ⁽¹⁾	Х	Χ	High Z
Program Inhibit	Х	Х	ViH		
Program Inhibit	Х	VIL	Χ		
Output Disable	Х	VIH	Х		High Z
Product Identification	M	V.	Mari	A1-A15 = V_{IL} , A9 = V_{H} (3), A0 = V_{IL}	Manufacturer Code ⁽⁴⁾
Hardware	VIL	ViL	ViH	A1-A15 = V _{IL} , A9 = V _H ⁽³⁾ , A0 = V _{IH}	Device Code ⁽⁴⁾
Software ⁽⁵⁾			·	A0 = V _{IL}	Manufacturer Code ⁽⁴⁾
Software."				A0 = V _{IH}	Device Code ⁽⁴⁾

Notes: 1. X can be V_{IL} or V_{IH} .

2. Refer to A.C. Programming Waveforms.

3. $V_H = 12.0 \text{ V} \pm 0.5 \text{ V}$.

4. Manufacturer Code: 1F, Device Code: 3D.

5. See details under Software Product Identification Entry/Exit.

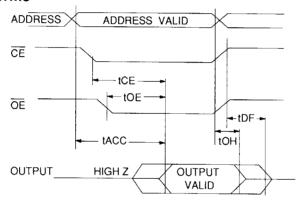
D.C. Characteristics

Symbol	Parameter	Condition		Min	Max	Units
ILI	Input Load Current	V _{IN} = 0 V to V _{CC}			11	μ Α
ILO	Output Leakage Current	V _{I/O} = 0 V to V _{CC}			1	μA
	V Canadha Canana Chica	CE = Vcc - 0.3 V to Vcc	Com.		20	μΑ
ISB1	Vcc Standby Current CMOS	CE = VCC - 0.3 V 10 VCC	Ind.		50	μА
ISB2	Vcc Standby Current TTL	CE = 2.0 V to Vcc			1	mA
Icc	Vcc Active Current	f = 5 MHz; lout = 0 mA; V	cc = 3.6 V		15	mA
ViL	Input Low Voltage				0.6	V
ViH	Input High Voltage			2.0		V
Vol	Output Low Voltage	IOL = 1.6 mA; Vcc = 3.0 V	1		.45	V
Voн	Output High Voltage	$I_{OH} = -100 \mu A; V_{CC} = 3.0$	٧	2.4		٧

A.C. Read Characteristics

Symbol Parameter		AT29LV512-20		AT29LV512-25		
		Parameter Min	Max	Mın	Max	Units
tacc	Address to Output Delay		200		250	ns
	CE to Output Delay		200		250	ns
toe (2)	OE to Output Delay	0	100	0	120	ns
t _{DF} (3,4)	CE or OE to Output Float	0	50	0	60	ns
tон	Output Hold from OE, CE or Address, whichever occurred first	0		0		ns

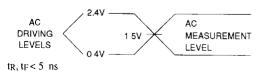
A.C. Read Waveforms



Notes:

- TE may be delayed up to tACC tCE after the address transition without impact on tACC.
- OE may be delayed up to t_{CE} t_{OE} after the falling edge of CE without impact on t_{CE} or by t_{ACC} - t_{OE} after an address change without impact on t_{ACC}
- 3 t_{DF} is specified from \overline{OE} or \overline{CE} whichever occurs first (CL = 5 pF).
- 4. This parameter is characterized and is not 100% tested.

Input Test Waveforms and Measurement Level



Output Test Load



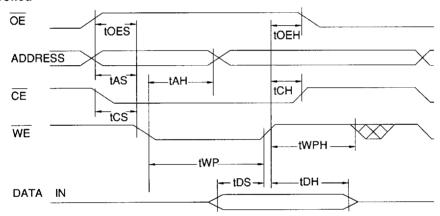


A.C. Byte Load Characteristics

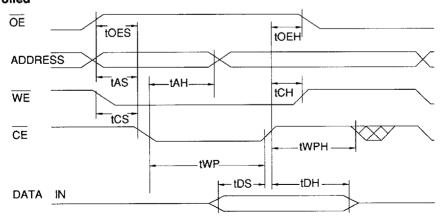
Symbol	Parameter	Min	Max	Units
tas, toes	Address, OE Set-up Time	10		ns
tah	Address Hold Time	100		ns
tcs	Chip Select Set-up Time	0		пѕ
tсн	Chip Select Hold Time	0		ns
twp	Write Pulse Width (WE or CE)	200		ns
tos	Data Set-up Time	100		ns
tDH,tOEH	Data, OE Hold Time	10		ns
twph	Write Pulse Width High	200		ns

A.C. Byte Load Waveforms (1,2)

WE Controlled



CE Controlled



Notes

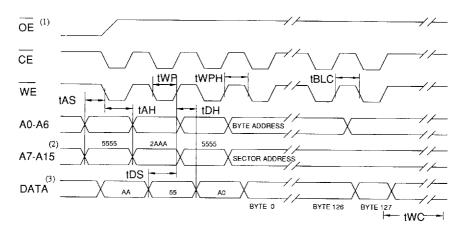
- 1. The software data protection commands must be applied prior to byte loads.
- A complete sector (128 bytes) should be loaded using these waveforms as shown in the Software Protected Byte Load waveforms (see previous page).

AT29LV512

Program Cycle Characteristics

Symbol	Parameter	Min	Max	Units
twc	Write Cycle Time		20	ms
tas	Address Set-up Time	10		ns
tah	Address Hold Time	100		ns
tos	Data Set-up Time	100		ns
tDH	Data Hold Time	10		ns
twp	Write Pulse Width	200		ns
tBLC	Byte Load Cycle Time		150	μѕ
tw _{PH}	Write Pulse Width High	200		ns

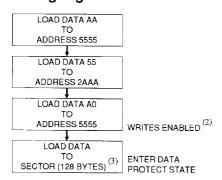
Software Protected Program Waveform



Notes:

- 1 \overline{OE} must be high when \overline{WE} and \overline{CE} are both low.
- A7 through A15 must specify the sector address during each high to low transition of WE (or CE) after the software code has been entered.
- 3 All bytes that are not loaded within the sector being programmed will be erased to FF.

Programming Algorithm (1)



Notes for software program code

- 1 Data Format I/O7-I/O0 (Hex); Address Format A14-A0 (Hex).
- 2. Data Protect state will be re-activated at end of program cycle
- 3. 128 bytes of data MUST BE loaded





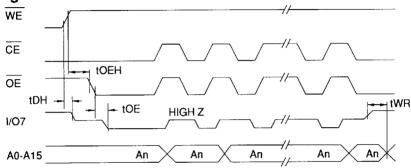
Data Polling Characteristics(1)

Symbol	Parameter	Min	Тур	Max	Units
t DH	Data Hold Time	10			ns
t OEH	OE Hold Time	10			ns
toe	OE to Output Delay ⁽²⁾				ns
twa	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See toE spec in A.C. Read Characteristics.

Data Polling Waveforms



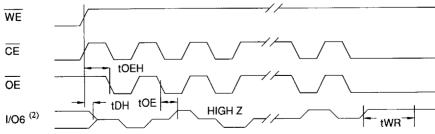
Toggle Bit Characteristics(1)

Symbol	Parameter	Min	Тур	Max	Units
tрн	Data Hold Time	10			ns
toeh	OE Hold Time	10			ns
toE	OE to Output Delay ⁽²⁾				ns
toehp	OE High Pulse	150			ns
twn	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See toE spec in A.C. Read Characteristics.

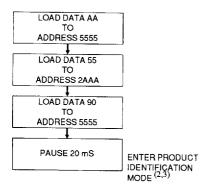
Toggle Bit Waveforms (1,3)



Notes

- 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit.
- 2. Beginning and ending state of I/O6 will vary.
- 3. Any address location may be used but the address should not vary.

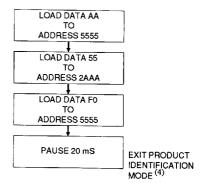
Software Product Identification Entry (1)



Notes for software product identification:

- Data Format: I/O7 I/O0 (Hex);
 Address Format: A14 A0 (Hex).
- A1 A15 = V_{II}.
 Manufacture Code is read for A0 = V_{II}.
 Device Code is read for A0 = V_{II}.
- The device does not remain in identification mode if powered down.
- 4. The device returns to standard operation mode.
- Manufacturer Code: 1F Device Code: 3D

Software Product (1) Identification Exit

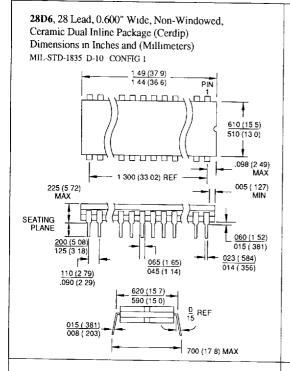


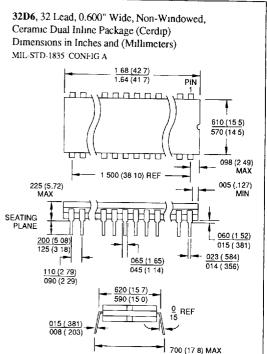


Ordering Information

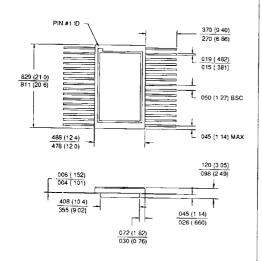
tacc	Icc (mA)		Ordering Code	Package	Operation Range
(ns)	Active	Standby	Ordering Code	Tackage	- Operation Hange
200	15	0.02	AT29LV512-20DC AT29LV512-20JC AT29LV512-20PC	32D6 32J 32P6 32D6 32J 32P6 32T 32D6	Commercial (0° to 70°C)
	15	0.05	AT29LV512-20DI AT29LV512-20JI AT29LV512-20PI AT29LV512-20TI	32J 32P6	Industrial (-40° to 85°C)
250	15	0.02	AT29LV512-25DC AT29LV512-25JC AT29LV512-25PC	JC 32J	Commercial (0° to 70°C)
	15	0.05	AT29LV512-25DI AT29LV512-25JI AT29LV512-25PI AT29LV512-25TI	32D6 32J 32P6 32T	Industrial (-40° to 85°C)

	Package Type					
32D6	32 Lead, 0.600" Wide, Non-Windowed, Ceramic Dual Inline Package (Cerdip)					
32J	32 Lead, Plastic J-Leaded Chip Carrier (PLCC)					
32P6	32 Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)					
32T	32 Lead, Thin Small Outline Package (TSOP)					

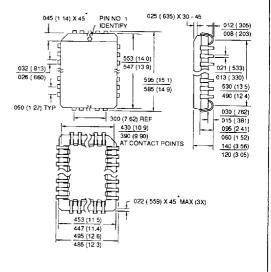




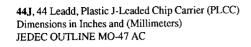
32F, 32 Lead, Non-Windowed, Ceramic Bottom Brazed Flat Package (Flatpack) Dimensions in Inches and (Millimeters) MIL-STD-1835 F-18 CONFIG B JEDEC OUTLINE MO-115

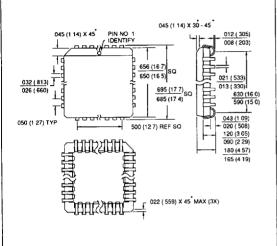


32J, 32 Leadd, Plastic J-Leaded Chip Carrier (PLCC) Dimensions in Inches and (Millimeters) JEDEC OUTLINE MO-52 AC

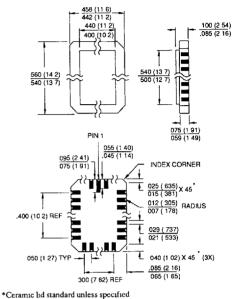




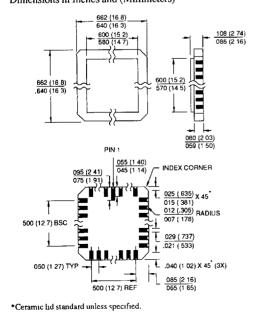




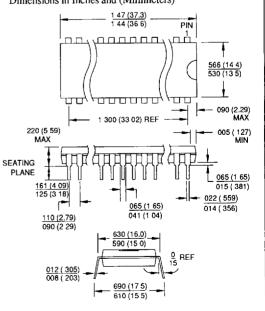
32L, 32 Pad, Non-Windowed, Ceramic Leadless Chip Carrier (LCC) Dimensions in Inches and (Millimeters)*

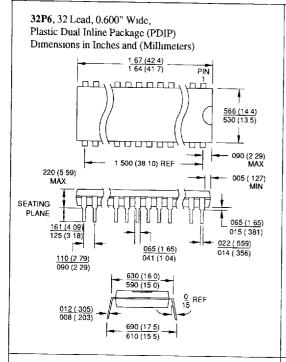


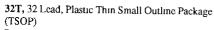
44L, 44 Pad, Non-Windowed, Ceramic Leadless Chip Carrier (LCC) Dimensions in Inches and (Millimeters)*

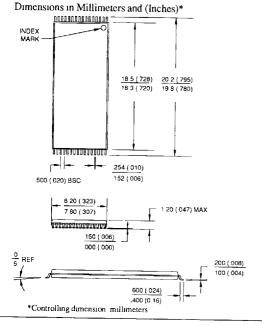


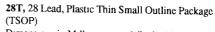
28P6, 28 Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP) Dimensions in Inches and (Millimeters)

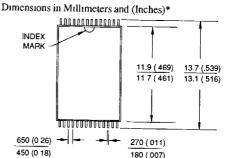


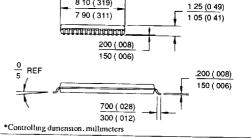












40T, 40 Lead, Plastic Thin Small Outline Package (TSOP)

Dimensions in Millimeters and (Inches)*

8 10 (319)

